TOSHIBA CMOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

T6K01

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COLUMN DRIVER LSI FOR A DOT MATRIX GRAPHIC LCD

The T6K01 is a column (segment) driver for a dot matrix graphic LCD. The T6K01 offers low power consumption, due to the CMOS Si-Gate process. It is designed to interface directly with a microprocessor unit (MPU). A program running on the MPU can drive the T6K01 asynchronously. The T6K01 stores data transferred from the MPU in its built-in RAM.

The data stored in the built-in display RAM corresponds to the image on the LCD screen; the data is converted into the LCD drive signal. A configuration of two T6K01s and one T6C03 can be used to drive a 480×160 -dot LCD.

Features

- Dot matrix graphic LCD column driver with display RAM
- Display RAM capacity: 160 lines × 240 outputs = 38400 bits
- LCD drive output: 240
- Interface: 8-bit MPU
- Relation between RAM data and display RAM bit data = 1 → display ON RAM bit data = 0 → display OFF
- Display OFF function
- Low power consumption
- Logic power supply: 2.7 to 3.3 V
- LCD power supply: 8.0 to 26.0 V
- CMOS Process
- Package: TCP (Tape Carrier Package)

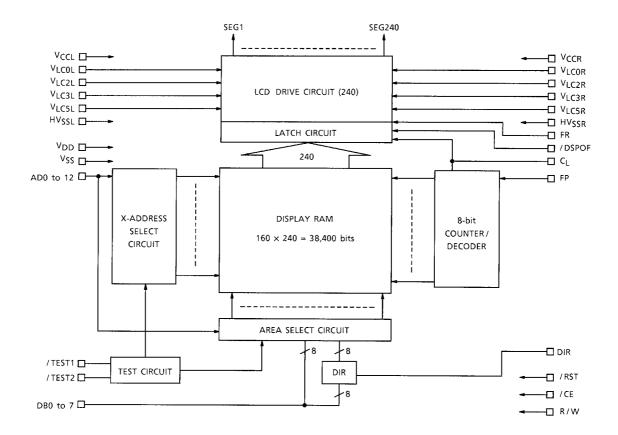
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T6K01	LEAD PITCH			
	IN	OUT		
(UAM, 4NS)	0.8	0.14		

Please contact Toshiba or an authorized Toshiba dealer for information on package dimensions.

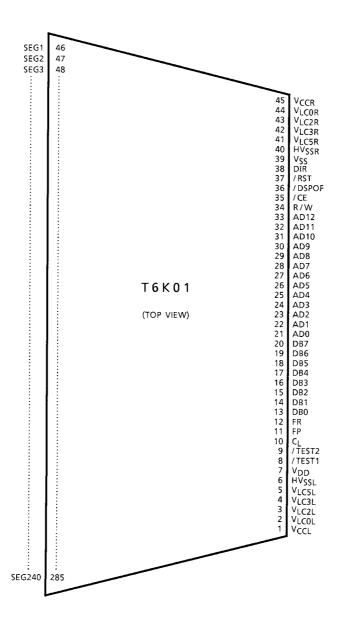
TCP (Tape Carrier Package)



Block Diagram



Pin Assignment



Note: The above diagram shows the pin configuration of the LSI chip; it does not show the configuration of the tape carrier package.



Pin Functions

Pin Name	Pin No.	1/0	Functions	
SEG1 to SEG240	46 to 285	Output	Column driver outputs	
C _L	10	Input	Shift clock pulse	
FP	11	Input	Display synchronous signal	
FR	12	Input	Frame signal	
DB0 to DB7	13 to 20	1/0	Data bus	
AD0 to AD12	21 to 33	Input	Address bus	
R/W	34	Input	Read / write select R / W = H → Read selected R / W = L → Write selected	
/ CE	35	Input	Chip enable Data write: Data write enabled on rising edge of / CE Data read: Data read out while / CE is at L level	
/ DSPOF	36	Input	Display off. Usually connected to V _{DD} . / DSPOF = H: Display-on mode. (SEG1 to SEG240) are operational. / DSPOF = L: Display-off mode. (SEG1 to SEG240) are at the V _{SS} level.	
/ RST	37	Input	Reset signal: / RST = L → Reset state	
DIR	38	Input	Data direction select	
/ TEST1, 2	8, 9	Input	Test pin. Usually connected to V _{DD}	
V_{DD}, V_{SS}	7, 39	_	Power supply	
VCCL, VCCR VLC0L, VLC0R VLC2L, VLC2R VLC3L, VLC3R VLC5L, VLC5R HVSSL, HVSSR	1, 45 2, 44 3, 43 4, 42 5, 41 6, 40	_	Power supply for LCD drive	

Function of Each Block

RAM cell

The RAM capacity is 160 lines \times 240 outputs for a total of 38400 bits.

DIR

This circuit changes the data flow direction and page selection sequence.

• Address decoder

This decoder selects one RAM address for read / write operation.

• 8-bit counter + decoder

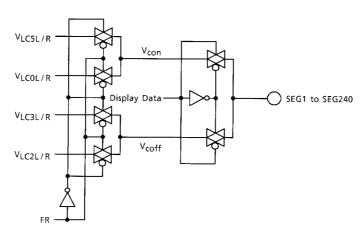
The decoder selects one RAM cell from the 160 address lines for display operation.

• Latch

The data is latched from the display RAM on the falling edge of CL.

• Column driver circuit and LCD voltage generation circuit

The T6K01 has 240 column drivers and four different LCD drive output voltage levels. The display data from the latch circuit and the M signal determine which of the four LCD drive voltages is selected. This circuit is shown in the following diagram.



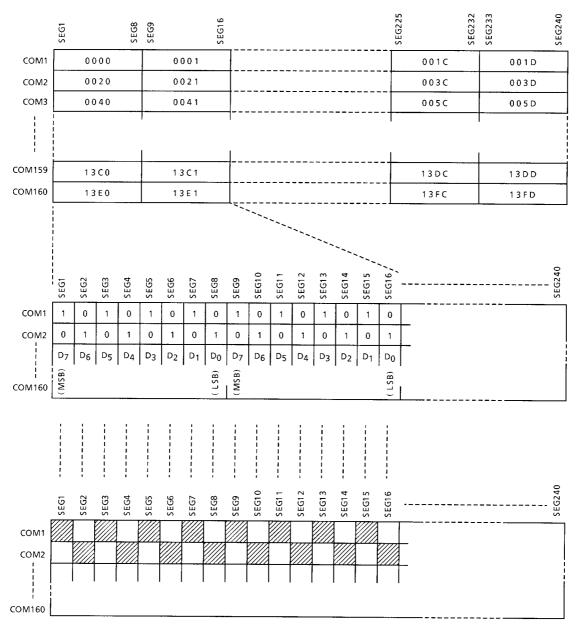
Relation Between FR, Data Input and Output Level

/ DSPOF	FR	Input Data (RAM Data)	Output Level
L	*	*	V _{SS} / V _{LC5}
Н	L	L	V_{LC3}
Н	L	Н	V_{SS} / V_{LC5}
Н	Н	L	V_{LC2}
Н	Н	Н	V_{LC0}

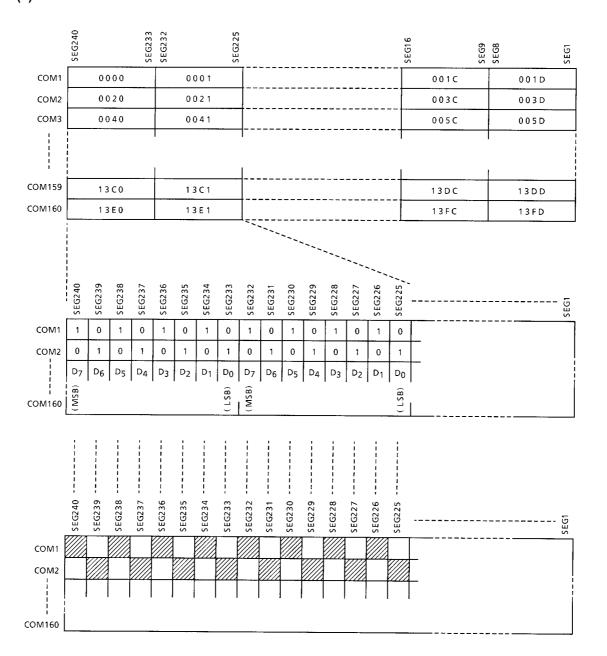
*: INVALID

• The relation between DIR and the memory map

(1) DIR = H



(2) DIR = L



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Absolute Maximum Ratings (Ta = 25°C)

Item	Symbol	Rating	Unit
Supply Voltage (1)	V _{DD} (Note 2)	-0.3 to 6.5	V
Supply Voltage (2)	(Note 1, 2)	-0.3 to 28.0	V
Input Voltage	V _{IN} (Note 2, 3)	-0.3 to V _{DD} +0.3	٧
Operating Temperature	T _{opr}	−20 to 75	°C
Storage Temperature	T _{stg}	-55 to 125	°C

Note 1: V_{CCL} , V_{CCR} , V_{LC0L} , V_{LC0R} , V_{LC2L} , V_{LC2R} , V_{LC3L} , V_{LC3R} , V_{LC5L} and V_{LC5R}

Note 2: Referenced to V_{SS} , HV_{SSL} and HV_{SSR} Note 3: Applies to all data bus and I / O pins.

Note 4: Ensure that the following condition is always maintained.

 $V_{CCL \ / \ R} \geq V_{LC0L} \ / \ R \geq V_{LC2L} \ / \ R \geq V_{LC3L \ / \ R} \geq V \ _{LC5L \ / \ R} \geq HV_{SSL \ / \ R}$

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Electrical Characteristics DC Characteristics Test Conditions (Unless Otherwise Noted, V_{SS} = 0 V, V_{DD} = 3.0 V ± 10%, $V_{CCL/R}$ = 23.0 V ± 10%, T_{AB} = -20 to 75°C)

Ite	Item Symbol		Test Circuit	Test Condition	Min	Тур.	Max	Unit	Pin Name	
Operating	Supply (1)	V_{DD}	_	_	2.7	_	3.3	V	V_{DD}	
Operating	Supply (2)	V _{CC}	_	_	8.0	_	26.0	V	V _{CCL} , V _{CCR}	
	H Level	V _{IH}	_	_	0.7 V _{DD}	_	V _{DD}	٧	DB0 to DB7 AD0 to AD7,	
Input Voltage L Level		V_{IL}	_	_	0		0.3 V _{DD}	>	/ RST, / DSPOF, / CE, R / W, D / I, C _L , FP, FR, DIR, / TEST	
Output	H Level	V _{OH}	_	I _{OH} = -400 μA	V _{DD} -0.4	_	V _{DD}	>	DB0 to DB7	
Voltage	L Level	V _{OL}	_	Ι _{ΟL} = 400 μΑ	V _{SS}	_	0.4	٧	אםט 10 טטטן	
Column Dr Output Re		R _{col}	_	Load current = ±100 μA (Note 4)	_	_	3.0	kΩ	SEG1 to SEG160	
Input Leak	age	I _{IL}	- V _{IN} = V _{DD} to V _{SS}		-1	_	1	μΑ	DB0 to DB7 AD0 to AD7, / RST, / DSPOF, / CE, R / W, D / I, C _L , FP, FR, DIR, / TEST	
Operating	Freq.	f _{CL}	_	_	10	_	50	kHz	C _L	
Current Consumption (1)		I _{SS1}	_	(Note 1)	_	410	520	μA	V _{SS} , HV _{SSL} , HV _{SSR} , V _{LC5L} , V _{LC5R}	
Current Co	Current Consumption (2)		_	(Note 2)	_	45	65	μA	V _{SS} , HV _{SSL} , HV _{SSR} , V _{LC5L} , V _{LC5R}	
Current Co	onsumption	lss3	_	(Note 3)	-1	_	1	μA	V _{SS} , HV _{SSL} , HV _{SSR} , V _{LC5L} , V _{LC5R}	

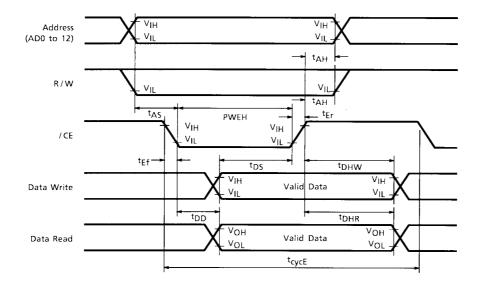
Note 1: Current consumption while internal data receiver is operating V_{DD} = 3.0 V ±10%, V_{CCL} / R = 23.0 V, Ta = 25°C, 1 / 13 bias, 1 / 160 duty, no load, f_{FP} = 70 Hz, f_{CE} = 5 MHz

Note 2: Current consumption while internal data receiver is sleeping V_{DD} = 3.0 V ±10%, $V_{CCL/R}$ = 23.0 V, Ta = 25°C, 1 / 13 bias, 1 / 160 duty, no load, f_{FP} = 70 Hz, f / CE = 0 Hz

Note 3: Standby current consumption V_{DD} = 3.0 V ±10%, $V_{CCL/R}$ = 23.0 V, Ta = 25°C, no load, f_{FP} = 0 Hz, $f_{/CE}$ = 0 Hz

Note 4: $V_{CCL/R} = V_{LC0L/R} = 23.0 \text{ V}$, $V_{LC2L/R} = V_{CC} \times 11 / 13$, $V_{LC3L/R} = V_{CC} \times 2 / 13$, $HV_{SSL/R} = V_{LC5L/R} = 0 \text{ V}$

AC Characteristics (1)



Test Conditions (Unless Otherwise Noted, V_{SS} = 0 V, V_{DD} = 3.0 V ±10%, Ta = -20 to 75°C)

Item	Symbol	Min	Max	Unit
Enable Cycle Time	t _{cycE}	250	_	ns
Enable Pulse Width	PWEH	160	_	ns
Enable Rise / Fall Time	t _{Er} , t _{Ef}	_	20	ns
Address Set-up Time	t _{AS}	0	_	ns
Address Hold Time	t _{AH}	10	_	ns
Data Set-up Time	t _{DS}	100	-	ns
Data Hold Time	t _{DHW}	20	-	ns
Data Delay Time	t _{DD} (Note)	_	180	ns
Data Hold Time	t _{DHR} (Note)	20	_	ns

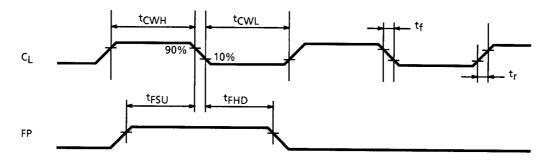
Load Circuit

C = 40 PF
(including wiring capacitance)

Note: With load circuit connected

AC Characteristics (2)

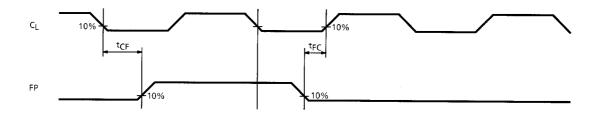
display data



Test Conditions (Unless Otherwise Noted, V_{SS} = 0 V, V_{DD} = 3.0 V \pm 10%, Ta = -20 to 75°C)

Item	Symbol	Pin Name	Min	Max	Unit
C _L Pulse Width H	t _{CWH}	CL	500	_	ns
C _L Pulse Width L	t _{CWL}	CL	500	_	ns
C _L Rise / Fall Time	t _r , t _f	CL	_	50	ns
FP Set-up Time	t _{FSU}	FP	100	_	ns
FP Hold Time	t _{FHD}	FP	100	_	ns

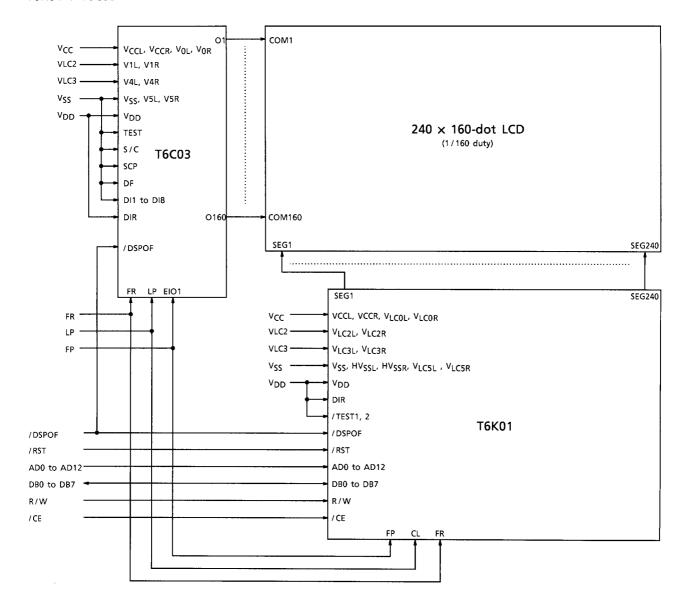
AC Characteristics (3)



Item	Symbol	Condition	Min	Max	Unit
C _L -to-FP-margin time	t _{CF}		20	-	ns
FP-to-C _L -margin time	t _{FC}		0	_	ns

Application Circuit

T6K01 + T6C03



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